

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10559857	FRALEY ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Loewe, Sun Jae Y	1609

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
STN Structure	6/12/2007	SL
PALM Inventor (all inventors)	6/13/2007	SL

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>